Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/551,048	APFELBACHER ET AL.
Examiner	Art Unit
Hae M. Hyeon	2839

	SEARCHED				
Class	Subclass	Date	Examiner		
439	76.1	6/01	hanh		
257	415				
361	93.1				
439	701				
361	141				
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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